Application/Control No.	Applicant(s)/Patent under Reexamination	
10/786,072	ISHII ET AL.	
Examiner	Art Unit	
Patrick A. Darno	2163	

	SEARCHED				
Class	Subclass	Date	Examiner		
707	009	4/26/2005	PAD		
718	104	4/26/2005	PAD		
340	5.28	4/26/2005	PAD		
709	218	4/26/2005	PAD		
709	104	4/26/2005	PAD		
709	229	4/26/2005	PAD		
455	410	4/26/2005	PAD		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	4/26/2005	PAD		
Consulted Etienne LeRoux	4/25/2006	PAD		
Consulted Hal Dodds	4/25/2006	PAD		